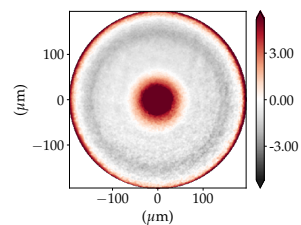
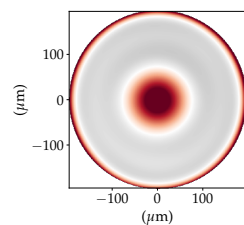


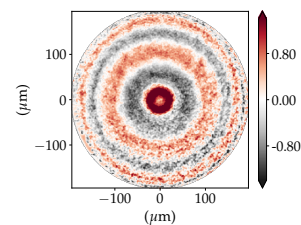
(a) horizontal and vertical cut



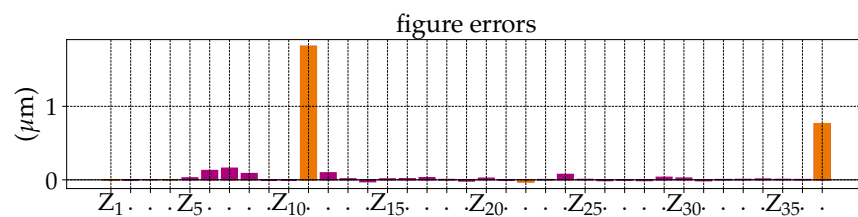
(b) full profile



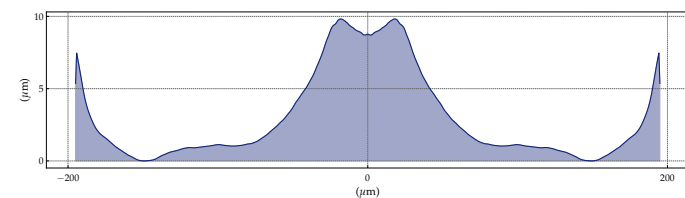
(c) polynomial fit



(d) residues

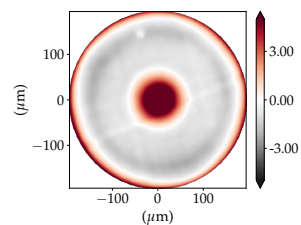


(e) azimuthally averaged profile

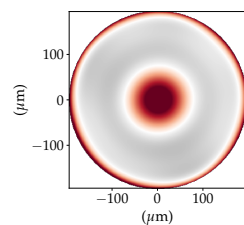


(f) azimuthal average of the full profile

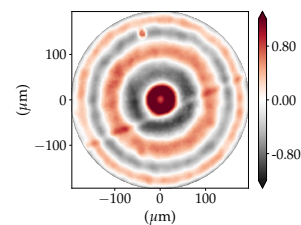
visible light metrology



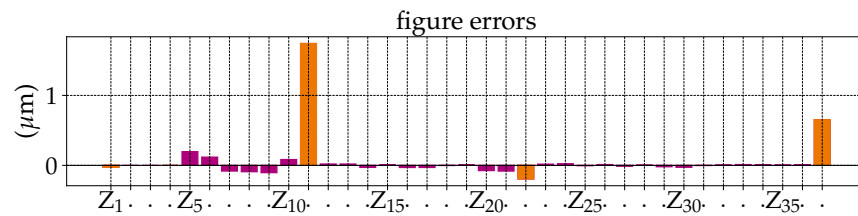
(g) full profile



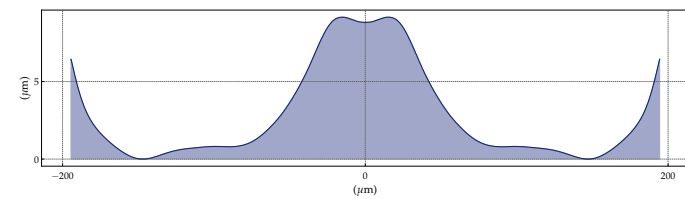
(h) polynomial fit



(i) residues



(j) azimuthally averaged profile



(k) azimuthal average of the full profile

at wavelength metrology